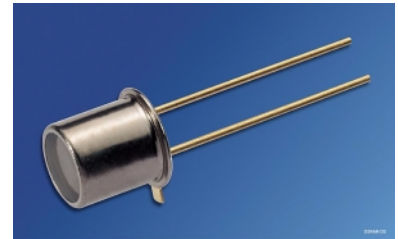


Silizium-PIN-Fotodiode Silicon PIN Photodiode

BPX 65



Wesentliche Merkmale

- Speziell geeignet für Anwendungen im Bereich von 350 nm bis 1100 nm
- BPX 65: Hohe Fotoempfindlichkeit
- Hermetisch dichte Metallbauform (TO-18), geeignet bis 125 °C

Anwendungen

- Schneller optischer Empfänger mit großer Modulationsbandbreite

Features

- Especially suitable for applications from 350 nm to 1100 nm
- BPX 65: high photosensitivity
- Hermetically sealed metal package (TO-18), suitable up to 125 °C

Applications

- Fast optical sensor of high modulation bandwidth

Typ Type	Bestellnummer Ordering Code	Gehäuse Package
BPX 65	Q62702-P27	18 A3 DIN 41870, planes Glasfenster, hermetisch dichtet Gehäuse, Lötspieße im 2.54-mm-Raster (² /10"), Anodenkennzeichnung: Nase am Gehäuseboden 18 A3 DIN 41870, flat glass lens, hermetically sealed package, solder tabs 2.54 mm (² /10") lead spacing, anode marking: projection at package bottom

Grenzwerte**Maximum Ratings**

Bezeichnung Parameter	Symbol Symbol	Wert Value	Einheit Unit
Betriebs- und Lagertemperatur Operating and storage temperature range	$T_{op}; T_{stg}$	- 40 ... + 125	°C
Löttemperatur (Lötstelle 2 mm vom Gehäuse entfernt bei Lötzeit $t \leq 3$ s) Soldering temperature in 2 mm distance from case bottom ($t \leq 3$ s)	T_S	230	°C
Sperrspannung Reverse voltage	V_R	50	V
Verlustleistung, $T_A = 25$ °C Total power dissipation	P_{tot}	250	mW

Kennwerte ($T_A = 25$ °C, Normlicht A, $T = 2856$ K)**Characteristics** ($T_A = 25$ °C, standard light A, $T = 2856$ K)

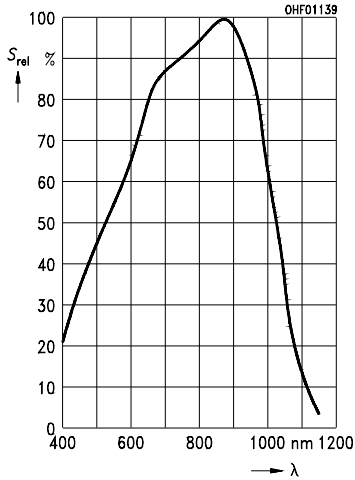
Bezeichnung Parameter	Symbol Symbol	Wert Value	Einheit Unit
Fotoempfindlichkeit, $V_R = 5$ V Spectral sensitivity	S	10 (≥ 5.5)	nA/lx
Wellenlänge der max. Fotoempfindlichkeit Wavelength of max. sensitivity	$\lambda_{S \max}$	850	nm
Spektraler Bereich der Fotoempfindlichkeit $S = 10\%$ von $S_{\max}$ Spectral range of sensitivity $S = 10\%$ of $S_{\max}$	λ	350 ... 1100	nm
Bestrahlungsempfindliche Fläche Radiant sensitive area	A	1.00	mm ²
Abmessung der bestrahlungsempfindlichen Fläche Dimensions of radiant sensitive area	$L \times B$ $L \times W$	1×1	mm
Abstand Chipoberfläche zu Gehäuseoberfläche Distance chip front to case surface	H	2.25 ... 2.55	mm
Halbwinkel Half angle	φ	± 40	Grad deg.
Dunkelstrom Dark current BPX 65: $V_R = 20$ V	I_R	1 (≤ 5)	nA

Kennwerte ($T_A = 25\text{ °C}$, Normlicht A, $T = 2856\text{ K}$)

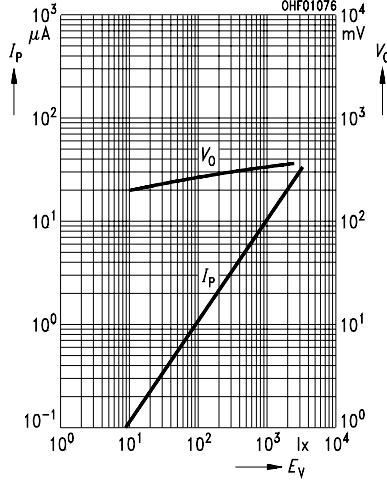
Characteristics ($T_A = 25\text{ °C}$, standard light A, $T = 2856\text{ K}$) (cont'd)

Bezeichnung Parameter	Symbol Symbol	Wert Value	Einheit Unit
Spektrale Fotoempfindlichkeit, $\lambda = 850\text{ nm}$ Spectral sensitivity	S_λ	0.55	A/W
Quantenausbeute, $\lambda = 850\text{ nm}$ Quantum yield	η	0.80	Electrons Photon
Leerlaufspannung, $E_V = 1000\text{ lx}$ Open-circuit voltage	V_L	320 (≥ 270)	mV
Kurzschlußstrom, $E_V = 1000\text{ lx}$ Short-circuit current	I_K	10	μA
Anstiegs und Abfallzeit des Fotostromes Rise and fall time of the photocurrent $R_L = 50\text{ }\Omega$; $V_R = 5\text{ V}$; $\lambda = 850\text{ nm}$; $I_p = 800\text{ }\mu\text{A}$	t_r, t_f	12	ns
Durchlaßspannung, $I_F = 100\text{ mA}$, $E = 0$ Forward voltage	V_F	1.3	V
Kapazität, $V_R = 0\text{ V}$, $f = 1\text{ MHz}$, $E = 0$ Capacitance	C_0	11	pF
Temperaturkoeffizient von V_L Temperature coefficient of V_L	TC_V	-2.6	mV/K
Temperaturkoeffizient von I_K Temperature coefficient of I_K	TC_I	0.2	%/K
Rauschäquivalente Strahlungsleistung Noise equivalent power $V_R = 20\text{ V}$, $\lambda = 850\text{ nm}$	NEP	3.3×10^{-14}	$\frac{\text{W}}{\sqrt{\text{Hz}}}$
Nachweisgrenze, $V_R = 20\text{ V}$, $\lambda = 850\text{ nm}$ Detection limit	D^*	3.1×10^{12}	$\frac{\text{cm} \times \sqrt{\text{Hz}}}{\text{W}}$

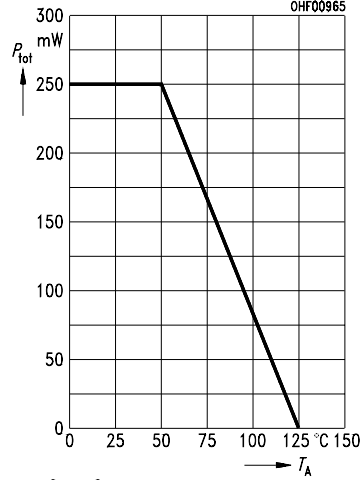
Relative Spectral Sensitivity
 $S_{rel} = f(\lambda)$



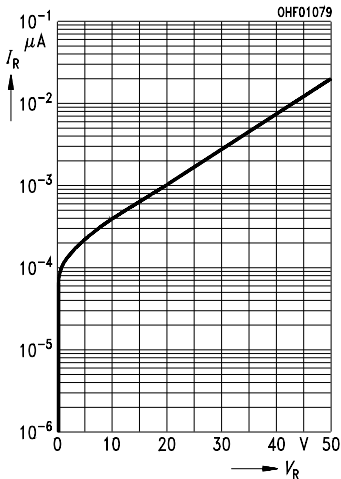
Photocurrent $I_P = f(E_V)$, $V_R = 5$ V
Open-Circuit-Voltage $V_L = f(E_V)$



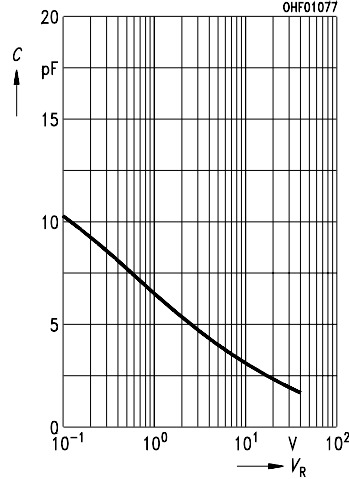
Total Power Dissipation
 $P_{tot} = f(T_A)$



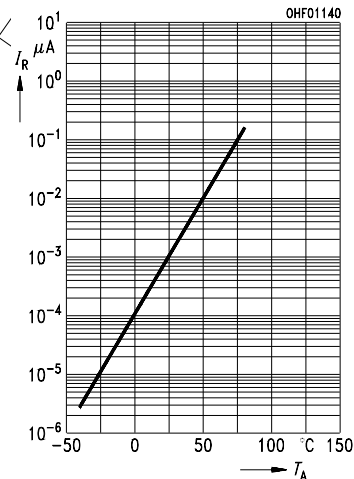
Dark Current
 $I_R = f(V_R), E = 0$



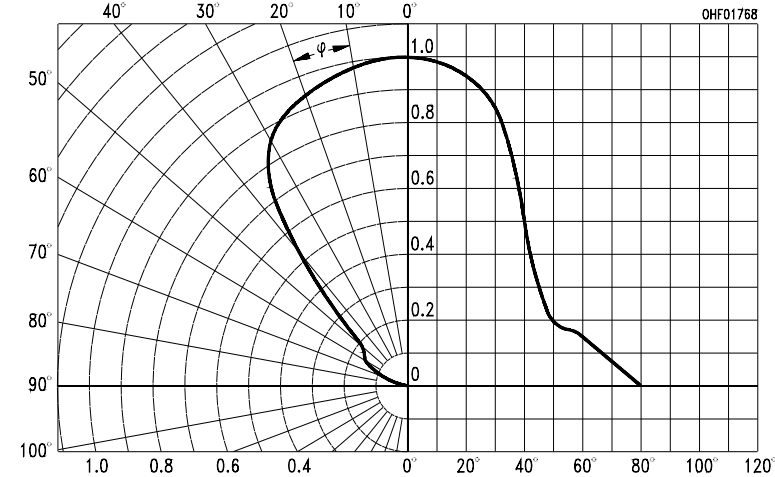
Capacitance
 $C = f(V_R), f = 1$ MHz, $E = 0$



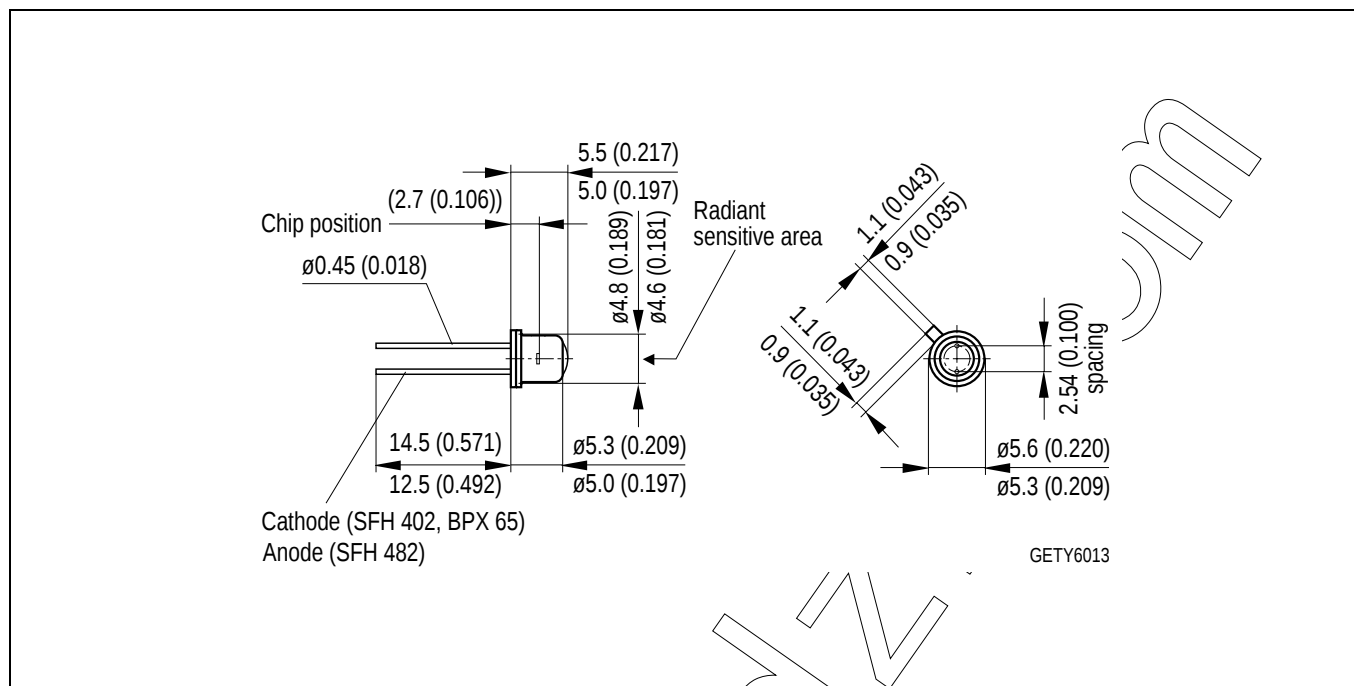
Dark Current
 $I_R = f(T_A), V_R = 20$ V, $E = 0$



Directional Characteristics
 $S_{rel} = f(\phi)$



Maßzeichnung Package Outlines



Maße werden wie folgt angegeben: mm (inch) / Dimensions are specified as follows: mm (inch).

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Attention please!

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Packing

Please use the recycling operators known to you. We can also help you – get in touch with your nearest sales office. By agreement we will take packing material back, if it is sorted. You must bear the costs of transport. For packing material that is returned to us unsorted or which we are not obliged to accept, we shall have to invoice you for any costs incurred.

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² Life support devices or systems are intended (a) to be implanted in the human body, or (b) to support and/or maintain and sustain human life. If they fail, it is reasonable to assume that the health of the user may be endangered.